Estimation and Testing Procedures for the Reliability Functions of a Family of Lifetime Distributions Based on Records

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Abstract: A family of lifetime distributions is considered. Two measures of reliability are considered, R(t) = P(X > t) and P = P(X > Y). Point estimation and testing procedures are developed for R(t) and P based on records. Two types of point estimators are developed - uniformly minimum variance unbiased estimators (UMVUES) and maximum likelihood estimators (MLES). A comparative study of different methods of estimation is done through simulation studies. Testing procedures are developed for the hypothesis related to different parametric functions.

Keywords and Phrases: family of lifetime distributions; point estimation; testing procedures; records; simulation studies.

1. Introduction

The reliability function R(t) is defined as the probability of failure-free operation until time t. Thus, if the random variable (rv) X denotes the lifetime of an item or a system, then R(t) = P(X > t). Another measure of reliability under stress-strength setup is the probability P = P(X > Y), which represents the reliability of an item or a system of random strength X subject to random stress Y. In engineering, stress is a solid body (liquids do not admit engineering stress) arises due to applied loads and is defined as "the force per unit area that one part of the body exerts on adjacent parts". Psychological stress is another type of stress. A lot of work has been done in the literature for the point estimation and testing of R(t) and P. For example, Pugh (1963), Basu (1964), Bartholomew (1957, 1963), Tong (1974, 1975), Johnson (1975), Kelley, Kelley and Schucany (1976), Sathe and Shah (1981), Chao (1982), Chaturvedi and Surinder (1999) developed inferential procedures for R(t) and P for exponential distribution. Constantine, Karson and Tse (1986) derived UMVUE and MLE for P associated with gamma distribution. Awad and Gharraf (1986) estimated P for Burr distribution. For estimation of R(t) corresponding to Maxwell and generalized Maxwell distributions, one may refer to Tyagi and Bhattacharya (1981) and Chaturvedi and Rani (1998), respectively. Inferences have been drawn for R(t) and P for some families of lifetime distributions by Chaturvedi and Rani (1997), Chaturvedi and Tomer (2003), Chaturvedi and Singh (2006, 2008) and Chaturvedi and Kumari (2015). Chaturvedi and Tomer (2002) derived UMVUE for R(t) and P for negative binomial distribution. For exponentiated Weibull and Lomax distributions, the inferential procedures are available in Chaturvedi and Pathak (2012, 2013, 2014).

Chandler (1952) introduced the concept of record values. Based on records, inferential procedures for the parameters of different distributins have been developed by Glick (1978), Nagaraja (1988a,1988b), Balakrishan, Ahsanullah and Chan (1995), Arnold, Balakrishan and Nagaraja (1992), Habibi Rad, Arghami and Ahmadi (2006), Arashi and Emadi (2008), Razmkhah and Ahmadi (2011), Arabi Belaghi, Arashi and Tabatabaey (2015) and others.

No one can resist being interested in record values. The hottest day ever, the longest winning streak in professional basketball, the lowest stock market figure, these we cannot resist. To the best of the knowledge of authors, no inferential procedures are available in the literature for the estimation and testing of reliability functions based on records. The records take values in life-testing experiments also.

The purpose of this paper is many-fold. We consider a family of lifetime distributions, which covers as many as fourteen distributions as its specific cases. We develop point estimation and testing procedures based on records. As far as point estimation is concerned, we derive UMVUES and MLES. A new technique of obtaining these estimators is developed, in which first of all the estimators of powers of parameter are obtained. These estimators are used to obtain estimators of R(t). Using the derivatives of the estimators of R(t), the estimators of sampled probability density function (pdf), at a specified point, are obtained which are subsequently used to obtain estimators of P. The estimators of P are derived for the cases when X and Y belong to the same and different families of distributions. Test procedures are developed for different hypotheses.

In Section 2, we give the family of lifetime distributions. In Section 3 and Section 4, respectively, we develop point estimation procedures and testing procedures. Finally, in Section 5, we present numerical findings.

2. The Family of Lifetime Distributions

Let the rv X follow the distribution having the pdf

$$f(x; a, \lambda, \underline{\theta}) = \frac{G'(x; a, \underline{\theta})}{\lambda} \exp\left(-\frac{G(x; a, \underline{\theta})}{\lambda}\right); x > a \ge 0, \lambda > 0.$$
(2.1)

Here, $G(x; a, \underline{\theta})$ is a function of x and may also depend on the parameters a and $\underline{\theta}$. $\underline{\theta}$ may be vector valued. Moreover, $G(x; a, \underline{\theta})$ is a monotonically increasing function in x with $G(a; a, \underline{\theta}) = 0$, $G(\infty; a, \underline{\theta}) = \infty$ and $G'(x; a, \underline{\theta})$ denotes the derivative of $G(x; a, \underline{\theta})$ with respect to x.

We note that (2.1) represents a family of lifetime distributions since it covers the following lifetime distributions as specific cases:

- I. For $G(x; a, \underline{\theta}) = x$ and a = 0, we get the one-parameter exponential distribution [Johnson and Kotz (1970, p.166)].
- II. For $G(x; a, \underline{\theta}) = x^p$ (p > 0) and a = 0, it turns out to be Weibull distribution [Johnson and Kotz (1970, p.250)].
- III. For $G(x; a, \underline{\theta}) = x^2$ and a = 0, it gives Rayleigh distribution [Sinha (1986, p.200)].
- IV. For $G(x; a, \underline{\theta}) = \log(1 + x^b)$, b > 0 and a = 0, it leads us to Burr distribution [Burr (1942) and Cislak and Burr (1968)].
- V. For $(x; a, \underline{\theta}) = log(\frac{x}{a})$, we get Pareto distribution [Johnson and Kotz (1970, p.233)].

- VI. For $G(x; a, \underline{\theta}) = log\left(1 + \frac{x}{\nu}\right), \nu > 0$ and a = 0, it is called Lomax (1954) distribution.
- VII. For $G(x; a, \underline{\theta}) = log\left(1 + \frac{x^b}{v}\right), b > 0, v > 0$ and a = 0, it becomes Burr distribution with scale parameter v (> 0) [Tadikamalla (1980)].
- VIII. For $G(x; a, \underline{\theta}) = x^{\gamma} \exp(\nu x)$, $\gamma > 0$, $\nu > 0$ and a = 0, it gives the modified Weibull distribution of Lai *et al* (2003).
 - IX. For $G(x; a, \underline{\theta}) = (x a) + \frac{\nu}{\lambda} log(\frac{x + \nu}{a + \lambda}), \nu > 0, \lambda > 0$, we get the generalised Pareto distribution of Ljubo (1965).
 - X. For $G(x; a, \underline{\theta}) = bx + \frac{\theta}{2}x^2, \theta > 0, b > 0$ and a = 0, we get the linear exponential distribution [Mahmoud and Al-Nagar (2009)].
- XI. For $G(x; a, \underline{\theta}) = (1 + x^b)^{\theta} 1, b > 0, \theta > 0$ and a = 0, we get the generalised power Weibull distribution [Nikulin and Haghighi (2006)].
- XII. For $G(x; a, \underline{\theta}) = \frac{\beta}{b}(e^{bx} 1), \beta > 0, b > 0$ and a = 0, we get the Gompertz distribution [Khan and Zia (2009)].

XIII. For
$$G(x; a, \underline{\theta}) = (e^{x^{b}} - 1)$$
, $b > 0$ and $a = 0$, this gives Chen (2000) distribution.

XIV. For $G(x; a, \underline{\theta}) = (x - a)$, we get the two-parameter exponential distribution [Ahsanullah (1980)].

3. Point Estimation Procedures

Let $X_1, X_2, ...$ be an infinite sequence of independent and identically distributed (*iid*) *rvs* from (2.1). An observation X_j will be called an upper record value (or simply a record) if its value exceeds that of all previous observations. Thus X_j is a record if $X_j > X_i$ for every i < j.

The record time sequence $\{T_n, n \ge 0\}$ is defined as:

$$\begin{cases} T_0 = 1 & ; with probability 1 \\ T_n = min\{j : X_j > X_{T_{n-1}}\}; n \ge 1 \end{cases}$$

The record value sequence $\{R_n\}$ is then defined by:

$$R_n = X_{T_n}$$
; $n = 0, 1, 2, ...$

The likelihood function of the first n + 1 upper record values $R_0, R_1, R_2, ..., R_n$ is:

$$L(\lambda|R_0, R_1, R_2, \dots, R_n) = f(R_n; a, \lambda, \underline{\theta}) \prod_{i=0}^{n-1} \frac{f(R_i; a, \lambda, \underline{\theta})}{1 - F(R_i; a, \lambda, \underline{\theta})}$$

where $F(x; a, \lambda, \theta)$ is the distribution function of X. It is easy to see that

$$L(\lambda|R_0, R_1, R_2, \dots, R_n) = \frac{exp\left(\frac{-G(R_n; a, \underline{\theta})}{\lambda}\right)}{\lambda^{n+1}} \prod_{i=0}^n G'(R_i; a, \underline{\theta}).$$
(3.1)

The following theorem provides UMVUES of powers of λ . These estimators will be utilized to obtain the UMVUE of reliability functions.

Theorem 1: For $p \in (-\infty, \infty)$, $p \neq 0$, the UMVUE of λ^{-p} is given by:

$$\widetilde{\lambda^{-p}} = \begin{cases} \frac{\Gamma(n+1)}{\Gamma(n-p+1)} \left\{ G(R_n; a, \underline{\theta}) \right\}^{-p}; n > p-1 \\ 0; otherwise \end{cases}$$

Proof: It follows from (3.1) and factorisation theorem [see Rohtagi and Saleh (2012, p.361)] that $G(R_n; a, \underline{\theta})$ is a sufficient statistic for λ and the *pdf* of $G(R_n; a, \underline{\theta})$ is: $h(G(r_n; a, \underline{\theta})|\lambda)$

$$=\frac{G(r_n; a, \underline{\theta})^n}{\Gamma(n+1)\lambda^{n+1}} \exp\left\{\frac{-G(r_n; a, \underline{\theta})}{\lambda}\right\}$$
(3.2)

From (3.2), since the distribution of R_n belongs to exponential family, it is also complete [see Rohtagi and Saleh (2012, p.367)]. The result now follows from (3.2) that

$$E[G(R_n; a, \underline{\theta})^{-p}] = \left\{\frac{\Gamma(n-p+1)}{\Gamma(n+1)}\right\}\lambda^{-p}$$

In the following theorem, we obtain UMVUE of the reliability function.

Theorem 2: The UMVUE of the reliability function is

$$\tilde{R}(t) = \begin{cases} \left[1 - \frac{G(t;a,\underline{\theta})}{G(R_n;a,\underline{\theta})}\right]^n ; & G(t;a,\underline{\theta}) < G(R_n;a,\underline{\theta}) \\ 0 & ; & otherwise \end{cases}$$

Proof: It is easy to see that

$$R(t) = exp\left\{\frac{-G(t; a, \underline{\theta})}{\lambda}\right\}$$
$$= \sum_{i=0}^{\infty} \frac{(-1)^{i}}{i!} \left\{\frac{G(t; a, \underline{\theta})}{\lambda}\right\}^{i}$$
(3.3)

Applying Theorem 1, it follows from (3.3) that

$$\widetilde{R}(t) = \sum_{i=0}^{\infty} \frac{(-1)^{i}}{i!} \{G(t; a, \underline{\theta})\}^{i} \widetilde{\lambda^{-i}}$$
$$= \sum_{i=0}^{n} (-1)^{i} {n \choose i} \{\frac{G(t; a, \underline{\theta})}{G(R_{n}; a, \underline{\theta})}\}^{i}$$

and the theorem follows.

The following corollary provides UMVUE of the sampled pdf. This estimator is derived with the help of Theorem 2.

Corollary 1: The UMVUE of the sampled *pdf* (2.1) at a specified point *x* is $\tilde{f}(x; a, \lambda, \underline{\theta}) = \begin{cases} \frac{nG'(x; a, \underline{\theta})}{G(R_n; a, \underline{\theta})} \left[1 - \frac{G(x; a, \underline{\theta})}{G(R_n; a, \underline{\theta})} \right]^{n-1}; G(x; a, \underline{\theta}) < G(R_n; a, \underline{\theta}) \\ 0 ; otherwise \end{cases}$

Proof: We note that the expectation of $\int_{t}^{\infty} f(x; a, \lambda, \underline{\theta}) dx$ with respect to R_{n} is R(t). Hence,

$$\tilde{R}(t) = \int_{t}^{\infty} \tilde{f}(x; a, \lambda, \underline{\theta}) dx$$

The result follows from Theorem 2.

In the following theorem, we obtain expression for the variance of $\tilde{R}(t)$, which will be needed to study its efficiency.

Theorem 3: The variance of $\tilde{R}(t)$ is given by:

$$\begin{aligned} \operatorname{Var}\{\tilde{R}(t)\} &= \frac{1}{n!} \left\{ \frac{G(t;a,\underline{\theta})}{\lambda} \right\}^{(n+1)} exp\left\{ \frac{-G(t;a,\underline{\theta})}{\lambda} \right\} \left[\frac{\lambda a_n}{G(t;a,\underline{\theta})} \\ &- a_{n-1} exp\left\{ \frac{G(t;a,\underline{\theta})}{\lambda} \right\} E_i \left(\frac{-G(t;a,\underline{\theta})}{\lambda} \right) \\ &+ \sum_{i=0}^{n-2} a_i \left\{ \sum_{m=1}^{n-i-1} \frac{(m-1)!}{(n-i-1)!} \left(\frac{-G(t;a,\underline{\theta})}{\lambda} \right)^{n-i-m-1} \\ &- \frac{1}{(n-i-1)!} \left(\frac{-G(t;a,\underline{\theta})}{\lambda} \right)^{n-i-1} exp\left(\frac{G(t;a,\underline{\theta})}{\lambda} \right) E_i \left(\frac{-G(t;a,\underline{\theta})}{\lambda} \right) \right\} \\ &+ \sum_{i=n+1}^{2n} a_i (i-n)! \left(\frac{\lambda}{G(t;a,\underline{\theta})} \right)^{i-n+1} \sum_{r=0}^{n-1} \frac{1}{r!} \left(\frac{G(t;a,\underline{\theta})}{\lambda} \right)^r \right] \\ &- exp\left\{ \frac{-2G(t;a,\underline{\theta})}{\lambda} \right\}, \end{aligned}$$
(3.4)

where $a_i = (-1)^i {\binom{2n}{i}}$ and $-E_i(-x) = \int_x^{\infty} \frac{du}{u} du$. **Proof:** Using (3.2) and Theorem 2,

$$E\{\tilde{R}(t)^2\}$$

$$= \frac{1}{\Gamma(n+1)\lambda^{n+1}} \int_{G(t;a,\underline{\theta})}^{\infty} \left[1 - \frac{G(t;a,\underline{\theta})}{G(r_n;a,\underline{\theta})} \right]^{2n} \left\{ G(r_n;a,\underline{\theta}) \right\}^n exp\left\{ \frac{-G(r_n;a,\underline{\theta})}{\lambda} \right\} dG(r_n;a,\underline{\theta})$$
$$= \frac{1}{\Gamma(n+1)} \left(\frac{G(t;a,\underline{\theta})}{\lambda} \right)^{n+1} exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda} \right) \int_{0}^{\infty} \frac{u^{2n}}{(1+u)^n} exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda} u \right) du$$

$$=\frac{1}{\Gamma(n+1)} \left(\frac{G(t;a,\underline{\theta})}{\lambda}\right)^{n+1} exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}\right) I, \quad (say)$$
where
$$(3.5)$$

$$I = \sum_{i=0}^{n} a_{i} \int_{0}^{\infty} \frac{1}{(u+1)^{n-i}} \exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}u\right) du + \sum_{i=n+1}^{2n} a_{i} \int_{0}^{\infty} (u+1)^{i-n} \exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}u\right) du$$
(3.6)

Using a result of Erdélyi (1954) that

$$\int_{0}^{\infty} \frac{\exp(-up)}{(u+a)^{n}} du = \sum_{m=1}^{n-1} \frac{(m-1)! (-p)^{n-m-1}}{(n-1)! a^{m}} - \frac{(-p)^{n-1}}{(n-1)!} \exp(ap) E_{i}(-ap)$$
we have
$$\int_{0}^{\infty} \frac{1}{(u+1)^{n-i}} \exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}u\right) du$$

$$= \sum_{m=1}^{n-i-1} \frac{(m-1)!}{(n-1)!} \left(\frac{-G(t;a,\underline{\theta})}{\lambda}\right)^{n-i-m-1}$$

$$- \frac{1}{(n-i-1)!} \left(\frac{-G(t;a,\underline{\theta})}{\lambda}\right)^{n-i-1} \exp\left(\frac{G(t;a,\underline{\theta})}{\lambda}\right) E_{i} \left(\frac{-G(t;a,\underline{\theta})}{\lambda}\right), i = 0, 1, 2, ..., n-2$$
(3.7)

Furthermore,

$$\int_{0}^{\infty} \frac{1}{(1+u)} \exp\left(\frac{-G\left(t;a,\underline{\theta}\right)}{\lambda}u\right) du$$

$$= \exp\left(\frac{G\left(t;a,\underline{\theta}\right)}{\lambda}\right) \int_{0}^{\infty} \frac{1}{1+u} \exp\left(\frac{-G\left(t;a,\underline{\theta}\right)}{\lambda}(1+u)\right) du$$

$$= \exp\left(\frac{G\left(t;a,\underline{\theta}\right)}{\lambda}\right) \int_{\left(\frac{G\left(t;a,\underline{\theta}\right)}{\lambda}\right)}^{\infty} \frac{e^{-z}}{z} dz$$

$$= -\exp\left(\frac{G\left(t;a,\underline{\theta}\right)}{\lambda}\right) E_{i}\left(\frac{-G\left(t;a,\underline{\theta}\right)}{\lambda}\right).$$
(3.8)
We have

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$$\int_{0}^{\infty} exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}u\right) du = \left(\frac{G(t;a,\underline{\theta})}{\lambda}\right)$$
(3.9)

Finally,

$$\int_{0}^{\infty} (1+u)^{i-n} exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}u\right) du = \sum_{r=0}^{i-n} {i-n \choose r} \int_{0}^{\infty} u^{i-n-r} exp\left(\frac{-G(t;a,\underline{\theta})}{\lambda}u\right) du$$
$$= \sum_{r=0}^{i-n} {i-n \choose r} \left\{\frac{\lambda}{G(t;a,\underline{\theta})}\right\}^{i-n-r+1} \Gamma(i-n-r+1). (3.10)$$

The theorem now follows on making substitutions from (3.7), (3.8), (3.9) and (3.10) in (3.6) and then using (3.5).

Let X and Y be two independent rvs following the families of distributions $f_1(x; a_1, \lambda_1, \underline{\theta_1})$ and $f_2(y; a_2, \lambda_2, \underline{\theta_2})$ respectively. We consider the case when X and Y belong to different families of distributions, i.e.

$$f_1\left(x;a_1,\lambda_1,\underline{\theta_1}\right) = \frac{G'\left(x;a_1,\underline{\theta_1}\right)}{\lambda_1} \exp\left\{\frac{-G\left(x;a_1,\underline{\theta_1}\right)}{\lambda_1}\right\}; \qquad x > a_1 \ge 0, \lambda_1 > 0$$

and

$$f_2\left(y;a_2,\lambda_2,\underline{\theta_2}\right) = \frac{H'\left(y;a_2,\underline{\theta_2}\right)}{\lambda_2} \exp\left\{\frac{-H\left(y;a_2,\underline{\theta_2}\right)}{\lambda_2}\right\}; \qquad y > a_2 \ge 0, \lambda_2 > 0$$

Let $\{R_n\}$ and $\{R_m^*\}$ be the record value sequences for X's and Y's respectively.

The following theorem provides the UMVUE of P when X and Y belong to different families of distributions.

Theorem 4: The UMVUE of *P* is given by

$$\tilde{P} = \begin{cases} \frac{H(R_{n};a_{2},\underline{\theta_{2}})}{H(R_{m}^{*};a_{2},\underline{\theta_{2}})} \\ m \int_{0}^{0} (1-z)^{m-1} \left[1 - \frac{G\left(H^{-1}\left(zH\left(R_{m}^{*};a_{2},\underline{\theta_{2}}\right)\right)\right)}{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)} \right]^{n} dz ; R_{n} < R_{m}^{*} \\ m \int_{0}^{1} (1-z)^{m-1} \left[1 - \frac{G\left(H^{-1}\left(zH\left(R_{m}^{*};a_{2},\underline{\theta_{2}}\right)\right)\right)}{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)} \right]^{n} dz ; R_{m} < R_{m}^{*} \end{cases}$$

It follows from Corollary 1 that the UMVUES of $f_1(x; a_1, \lambda_1, \underline{\theta_1})$ and $f_2(y; a_2, \lambda_2, \underline{\theta_2})$ at specified points x and y are respectively:

$$\begin{split} \widetilde{f_{1}}\left(x;a_{1},\lambda_{1},\underline{\theta_{1}}\right) \\ &= \begin{cases} \frac{nG'\left(x;a_{1},\underline{\theta_{1}}\right)}{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)} \left[1 - \frac{G\left(x;a_{1},\underline{\theta_{1}}\right)}{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)}\right]^{n-1}; G\left(x;a_{1},\underline{\theta_{1}}\right) < G\left(R_{n};a_{1},\underline{\theta_{1}}\right) \\ 0 &; otherwise \end{cases} \end{split}$$

and

$$\begin{split} \widetilde{f}_{2}\left(y;a_{2},\lambda_{2},\underline{\theta_{2}}\right) \\ &= \begin{cases} \frac{mH'\left(y;a_{2},\underline{\theta_{2}}\right)}{H\left(R_{m}^{*};a_{2},\underline{\theta_{2}}\right)} \left[1 - \frac{H\left(y;a_{2},\underline{\theta_{2}}\right)}{H\left(R_{m}^{*};a_{2},\underline{\theta_{2}}\right)}\right]^{m-1}; H\left(y;a_{2},\underline{\theta_{2}}\right) < H\left(R_{m}^{*};a_{2},\underline{\theta_{2}}\right) \\ 0 ; otherwise \end{cases} \end{split}$$

From the arguments similar to those used in the proof of Corollary 1,

$$\tilde{P} = \iint_{y=a_2}^{\infty} \int_{x=y}^{\infty} \tilde{f}_1\left(x; a_1, \lambda_1, \underline{\theta_1}\right) \tilde{f}_2\left(y; a_2, \lambda_2, \underline{\theta_2}\right) dx \, dy$$

$$= \int_{y=a_2}^{\infty} \tilde{R}_1(y) \left\{ -\frac{d}{dy} \tilde{R}_2(y) \right\} dy$$

$$= m \int_{y=a_2}^{\min[R_n, R_m^*]} \left[1 - \frac{G\left(y; a_1, \underline{\theta_1}\right)}{G\left(R_n; a_1, \underline{\theta_1}\right)} \right]^n \left\{ \frac{H'\left(y; a_2, \underline{\theta_2}\right)}{H\left(R_m^*; a_2, \underline{\theta_2}\right)} \right\} \left[1 - \frac{H\left(y; a_2, \underline{\theta_2}\right)}{H\left(R_m^*; a_2, \underline{\theta_2}\right)} \right]^{m-1} dy$$

The theorem now follows on considering the two cases and putting $H\left(R_m^*; a_2, \underline{\theta_2}\right)^{-1} H\left(y; a_2, \underline{\theta_2}\right) = z$

In the following theorem, we obtain the UMVUE of P when X and Y belong to same families of distributions.

Theorem 5: When *X* and *Y* belong to same families of distributions,

$$\tilde{P} = \begin{cases} \sum_{i=0}^{m-1} \frac{(-1)^{i} m! n!}{(m-i-1)! (n+i+1)!} \left\{ \frac{G\left(R_{n}; a_{1}, \underline{\theta_{1}}\right)}{G\left(R_{m}^{*}; a_{1}, \underline{\theta_{1}}\right)} \right\}^{i+1}; R_{n} < R_{m}^{*} \\ \sum_{i=0}^{n} \frac{(-1)^{i} n! m!}{(n-i)! (m+i)!} \left\{ \frac{G\left(R_{m}^{*}; a_{1}, \underline{\theta_{1}}\right)}{G\left(R_{n}; a_{1}, \underline{\theta_{1}}\right)} \right\}^{i} ; R_{m}^{*} < R_{m}^{*} \end{cases}$$

Proof: Taking $G(\cdot) = H(\cdot)$ in Theorem 4, for $R_n < R_m^*$, $G(R_n;a_1,\theta_1)$

$$\begin{split} \tilde{P} &= m \int_{0}^{\frac{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)}{G\left(R_{m}^{*};a_{1},\underline{\theta_{1}}\right)}} dz \\ &= m \left\{ \frac{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)}{G\left(R_{m}^{*};a_{1},\underline{\theta_{1}}\right)} \right\}_{0}^{1} \left\{ 1 - \frac{uG\left(R_{n};a_{1},\underline{\theta_{1}}\right)}{G\left(R_{m}^{*};a_{1},\underline{\theta_{1}}\right)} \right\}^{m-1} (1-u)^{n} du \\ &= m \sum_{i=0}^{m-1} (-1)^{i} \binom{m-1}{i} \left\{ \frac{G\left(R_{n};a_{1},\underline{\theta_{1}}\right)}{G\left(R_{m}^{*};a_{1},\underline{\theta_{1}}\right)} \right\}^{i+1} \int_{0}^{1} u^{i} (1-u)^{n} du \end{split}$$

and the first assertion follows. Similarly, we can prove the second assertion.

The following theorem provides the MLE of R(t).

Theorem 6: The MLE of R(t) is given by:

$$\widehat{R}(t) = exp\left\{\frac{-(n+1)G(t; a, \underline{\theta})}{G(R_n; a, \underline{\theta})}\right\}$$

Proof: It can be easily seen from (3.1) that the MLE of λ is $\hat{\lambda} = \frac{G(R_n; a, \underline{\theta})}{n+1}$. The theorem now follows from invariance property of MLE.

In the following corollary, we obtain the MLE of sampled pdf with the help of Theorem 6. This will be used to obtain MLE of P.

Corollary 2: The MLE of $f(x; a, \lambda, \underline{\theta})$ at a specified point x is $\hat{f}(x; a, \lambda, \underline{\theta}) = \frac{(n+1)G'(x; a, \underline{\theta})}{G(R_n; a, \underline{\theta})} exp\left\{\frac{-(n+1)G(x; a, \underline{\theta})}{G(R_n; a, \underline{\theta})}\right\}$ **Proof:** The result follows from Theorem 6 on using the fact that $\hat{f}(x; a, \lambda, \underline{\theta}) = -\frac{d}{dt}\hat{R}(t).$

In the following theorem, we obtain the expression for variance of $\hat{R}(t)$.

Theorem 7: The variance of $\hat{R}(t)$ is given by:

$$\begin{aligned} \operatorname{Var}\{\widehat{R}(t)\} &= \frac{2}{n!} \left\{ \frac{2(n+1)G(t;a,\underline{\theta})}{\lambda} \right\}^{\frac{n+1}{2}} K_{n+1} \left(2\sqrt{\frac{2(n+1)G(t;a,\underline{\theta})}{\lambda}} \right) \\ &- \left[\frac{2}{n!} \left\{ \frac{(n+1)G(t;a,\underline{\theta})}{\lambda} \right\}^{\frac{n+1}{2}} K_{n+1} \left(2\sqrt{\frac{(n+1)G(t;a,\underline{\theta})}{\lambda}} \right) \right]^2 \end{aligned}$$

where $K_r(\cdot)$ is modified Bessel function of second kind of order r. **Proof:** Using (3.2) and Theorem 6, we have $E\{\hat{R}(t)\}$

$$=\frac{1}{\lambda^{n+1}\Gamma(n+1)}\int_{0}^{\infty} exp\left[-\left\{\frac{G(R_{n};a,\underline{\theta})}{\lambda}+\frac{(n+1)G(t;a,\underline{\theta})}{G(R_{n};a,\underline{\theta})}\right\}\right]\left\{G(R_{n};a,\underline{\theta})\right\}^{n}dG(R_{n};a,\underline{\theta})$$
$$=\frac{1}{\Gamma(n+1)}\int_{0}^{\infty} exp\left[-\left\{y+\frac{(n+1)G(t;a,\underline{\theta})}{\lambda y}\right\}\right]y^{n}dy$$
(3.11)

Applying a result of Watson (1952) that

$$\int_{0}^{\infty} u^{-m} \exp\left\{-\left(au + \frac{b}{u}\right)\right\} du = 2\left(\frac{a}{b}\right)^{\frac{m-1}{2}} K_{m-1}\left(2\sqrt{ab}\right)$$

[it is to be noted that $K_{-m}(\cdot) = K_m(\cdot)$ for m = 0, 1, 2, ...], we obtain from (3.11) that

$$E\{\hat{R}(t)\} = \frac{2}{n!} \left\{ \frac{(n+1)G(t;a,\underline{\theta})}{\lambda} \right\}^{\frac{n+1}{2}} K_{n+1} \left(2\sqrt{\frac{(n+1)G(t;a,\underline{\theta})}{\lambda}} \right)$$

Similarly, we can obtain the expression for $E\{\hat{R}(t)^2\}$ and the result follows.

The following theorem provides MLE of P when X and Y belong to different families of distributions.

Theorem 8: The MLE of P when X and Y belong to different families of distributions, is

$$\hat{P} = \int_{0}^{\infty} e^{-z} exp\left\{\frac{-(n+1)}{G\left(R_{n}; a_{1}, \underline{\theta_{1}}\right)} G\left(H^{-1}\left(\frac{zH(R_{m}^{*}; a_{2}, \underline{\theta_{2}})}{m+1}\right)\right)\right\} dz$$
Proof: We have

Proof: We have,

$$\begin{split} \hat{P} &= \iint_{\substack{y=a_2 \ x=y}}^{\infty} \widehat{f_1}\left(x; a_1, \lambda_1, \underline{\theta_1}\right) \widehat{f_2}\left(y; a_2, \lambda_2, \underline{\theta_2}\right) dx \, dy \\ &= \int_{\substack{y=a_2 \ y=a_2}}^{\infty} \widehat{R_1}\left(y; a_1, \underline{\theta_1}\right) \left\{ -\frac{d}{dy} \widehat{R_2}\left(y; a_2, \underline{\theta_2}\right) \right\} dy \\ &= \int_{\substack{y=a_2 \ y=a_2}}^{\infty} exp\left\{ \frac{-(n+1)G(y; a_1, \underline{\theta_1})}{G(R_n; a_1, \underline{\theta_1})} \right\} \left\{ \frac{(m+1)H'\left(y; a_2, \underline{\theta_2}\right)}{H\left(R_m^*; a_2, \underline{\theta_2}\right)} \right\} exp\left\{ \frac{-(m+1)H\left(y; a_2, \underline{\theta_2}\right)}{H\left(R_m^*; a_2, \underline{\theta_2}\right)} \right\} dy \\ \text{The result now follows on putting} \left\{ \frac{(m+1)H(y; a_2, \underline{\theta_2})}{H(R_m^*; a_2, \underline{\theta_2})} \right\} = z. \end{split}$$

The following theorem provides MLE of P when X and Y belong to same families of distributions. The result follows from Theorem 8.

Theorem 9: When X and Y belong to same families of distributions, the MLE of P is given by

$$\hat{P} = \frac{(m+1)G(R_n; a, \underline{\theta})}{(m+1)G(R_n; a, \underline{\theta}) + (n+1)G(R_m^*; a, \underline{\theta})}$$

4. Test Procedures For Various Hypotheses

Suppose we have to test the hypothesis $H_0: \lambda = \lambda_0$ against $H_1: \lambda \neq \lambda_0$. It follows from (3.1) that, under H_0 ,

$$\sup_{\Theta_{o}} L(\lambda|R_{0}, R_{1}, \dots, R_{n}) = \frac{1}{\lambda_{o}^{n+1}} exp\left\{\frac{-G(R_{n}; a, \underline{\theta})}{\lambda_{o}}\right\} \prod_{i=0}^{n} G'(R_{i}; a, \underline{\theta}); \ \Theta_{o} = \{\lambda : \lambda = \lambda_{o}\}$$

and

$$\sup_{\Theta} L(\lambda|R_0, R_1, \dots, R_n) = \left\{ \frac{n+1}{G(R_n; a, \underline{\theta})} \right\}^{n+1} exp(-(n+1)) \prod_{i=0}^n G'(R_i; a, \underline{\theta}); \ \Theta = \{\lambda : \lambda > 0\}$$

Therefore, the likelihood ratio (LR) is given by: $\sup_{L \in \mathcal{L}} L (\lambda | R - R) = R$

We note that the first term on the right hand side of (4.1) is monotonically increasing and the second term is monotonically decreasing in $G(R_n; a, \underline{\theta})$. It follows from (3.2) that $2\lambda_o^{-1}G(R_n; a, \underline{\theta}) \sim \chi^2_{2(n+1)}$. Thus, the critical region is given by $\{0 < G(R_n; a, \underline{\theta}) < k_o\} \cup$

 $\{k_{o}' < G(R_n; a, \underline{\theta}) < \infty\}$, where k_o and k_o' are obtained such that $k_o = \frac{\lambda_o}{2} \chi^2_{2(n+1)} \left(\frac{\alpha}{2}\right)$ and $k_{o}' = \frac{\lambda_{o}}{2} \chi_{2(n+1)}^{2} \left(1 - \frac{\alpha}{2}\right).$

An important hypothesis in life-testing experiments is $H_0: \lambda \ge \lambda_0$ against $H_1: \lambda < \lambda_0$. It follows from (3.1) that for $\lambda_1 > \lambda_2$,

$$\frac{L(\lambda_1|R_0, R_1, \dots, R_n)}{L(\lambda_2|R_0, R_1, \dots, R_n)} = \left(\frac{\lambda_2}{\lambda_1}\right)^{n+1} exp\left\{\left(\frac{1}{\lambda_2} - \frac{1}{\lambda_1}\right)G(R_n; a, \underline{\theta})\right\}$$
(4.2)

It follows from (4.2) that the family of distributions $f(x; a, \lambda, \underline{\theta})$ has monotone likelihood ratio in $G(R_n; a, \underline{\theta})$. Thus, the uniformly most powerful critical region for testing H_0 against H_1 is given by [see Lehmann (1959, p.88)]

 $\emptyset(R_0, R_1, \dots, R_n) = \begin{cases} 1 & ; \ G(R_n; a, \underline{\theta}) \leq k_o'' \\ 0 & ; \ otherwise \end{cases}$ where $k_{0}'' = \frac{\lambda_{0}}{2} \chi^{2}_{2(n+1)}(\alpha)$.

It can be seen that when X and Y belong to same families of distributions,

$$P = \frac{\lambda_1}{\lambda_1 + \lambda_2}$$

Suppose we want to test $H_0: P = P_0$ against $H_1: P \neq P_0$. It follows that H_0 is equivalent to $\lambda_1 = k\lambda_2$ where $k = \frac{P_0}{1 - P_0}$. Thus, $H_0: \lambda_1 = k\lambda_2$ and $H_1: \lambda_1 \neq k\lambda_2$.

It can be shown that, under H_0 ,

$$\hat{\lambda}_1 = \frac{G(R_n; a, \underline{\theta}) + kH(R_m^*; a, \underline{\theta})}{n + m + 2}$$

and

$$\hat{\lambda}_2 = \frac{G(R_n; a, \underline{\theta}) + kH(R_m^*; a, \underline{\theta})}{k(n+m+2)}$$

For a generic constant K,

$$L(\lambda_1, \lambda_2 | R_0, R_1, \dots, R_n, R_0^*, R_1^*, \dots, R_m^*) = \frac{K}{\lambda_1^{n+1} \lambda_2^{m+1}} exp\left\{-\left(\frac{G(R_n; a, \underline{\theta})}{\lambda_1} + \frac{H(R_m^*; a, \underline{\theta})}{\lambda_2}\right)\right\}$$

Thus,

$$\sup_{\Theta_{0}} L(\lambda_{1}, \lambda_{2} | R_{0}, R_{1}, \dots, R_{n}, R_{0}^{*}, R_{1}^{*}, \dots, R_{m}^{*}) = \frac{K}{\left\{\frac{G(R_{n}; a, \underline{\theta})}{k} + H(R_{m}^{*}; a, \underline{\theta})\right\}^{n+m+2}} exp\{-(n+m+2)\}; \Theta_{0} = \{\lambda_{1}, \lambda_{2}: \lambda_{1} = k\lambda_{2}\} \quad (4.3)$$
and

$$\sup_{\Theta} L(\lambda_{1}, \lambda_{2} | R_{0}, R_{1}, ..., R_{n}, R_{0}^{*}, R_{1}^{*}, ..., R_{m}^{*})$$

$$= \frac{K}{\left\{G(R_{n}; a, \underline{\theta})\right\}^{n+1} \left\{H(R_{m}^{*}; a, \underline{\theta})\right\}^{m+1}} exp\{-(n+m+2)\}; \Theta = \{\lambda_{1}, \lambda_{2}; \lambda_{1} > 0, \lambda_{2} > 0\}$$
(4.4)
From (4.3) and (4.4), the LR is:

$$\emptyset(R_0, R_1, \dots, R_n, R_0^*, R_1^*, \dots, R_m^*) = \frac{K\left\{\frac{H(R_m^*; a, \underline{\theta})}{G(R_n; a, \underline{\theta})}\right\}^{m+1}}{\left\{1 + \frac{kH(R_m^*; a, \underline{\theta})}{G(R_n; a, \underline{\theta})}\right\}^{n+m+2}}$$

Denoting by $F_{a,b}(\cdot)$, the F – Statistic with (a, b) degrees of freedom and using the fact that $\frac{G(R_{n};a,\underline{\theta})}{H(R_{m}^{*};a,\underline{\theta})} \sim \frac{(n+1)\lambda_{1}}{(m+1)\lambda_{2}} F_{2(n+1),2(m+1)}, \text{ the critical region is given by } \left\{ \frac{G(R_{n};a,\underline{\theta})}{H(R_{m}^{*};a,\underline{\theta})} < k_{2} \right\} \cup \left\{ \frac{G(R_{n};a,\underline{\theta})}{H(R_{m}^{*};a,\underline{\theta})} > k_{2}' \right\}, \text{ where } k_{2} = \frac{k(n+1)}{(m+1)} F_{2(n+1),2(m+1)} \left(\frac{\alpha}{2} \right) \text{ and } k_{2}' = \frac{k(n+1)}{(m+1)} F_{2(n+1),2(m+1)} \left(1 - \frac{\alpha}{2} \right).$

5. Numerical Findings

5.1 Real Data

We consider the real data set which was also used in Lawless (1982, p. 185). These data are from Nelson (1982), concerning the data on time to breakdown of an insulating fluid between electrodes at a voltage of 34 kV (minutes). The 19 times to breakdown are:

0.96 4.15 0.19 0.78 8.01 31.75 7.35 6.50 8.27 33.91 32.52 3.16 4.85 2.78 4.67 1.31 12.06 36.71 72.89

Therefore, we observe the following 7 upper record values:

0.96 4.15 8.01 31.75 33.91 36.71 72.89

We first apply Kolmogorov-Smirnov (K-S) test and Chi-Square test to check whether for a fixed voltage level, time to breakdown has a Weibull distribution. Considering Weibull distribution as a lifetime model for the complete data, the computed K-S statistic is 0.1616 with a p-value of 0.6462. The computed Chi-Square statistic is 0.5369 with a p-value of 0.4637. Both the tests indicate that Weibull Distribution is suitable for the data.

Using the method of Profile Log-likelihood before applying Newton-Raphson method, the Maximum Likelihood estimates of the parameters of Weibull distribution with scale parameter λ and shape parameter p obtained are $\hat{p} = 0.7708$, $\hat{\lambda} = 6.8865$. Based on these upper record values, $R_n = R_6 = 72.89$, $G(R_n) = G(R_6) = 27.2762$, reliability function $R(t)_{t=2} = 0.7894$, UMVUE of reliability function, $\tilde{R}(t)_{t=2} = 0.7345$, and MLE of reliability function, $\hat{R}(t)_{t=2} = 0.7041$.

Now we present a data analysis of the strength data reported by Badar and Priest(1982). This data represents the strength measured in GPA for single carbon fibers and impregnated 1000-carbon fiber tows. Single fibers were tested under tension at gauge lengths of 20mm (Data Set 1) and 10mm (Data Set 2) with sample sizes 69 and 63 respectively. These data have been used previously by Raqab and Kundu (2005), Kundu and Gupta (2006), Kundu and Raqab (2009) and Asgharzadeh et al (2011). Kundu and Gupta (2006) analyzed these data sets using two-parameter Weibull distribution after subtracting 0.75 from both these data sets. After subtracting 0.75 from all the points of these data sets, Kundu and Gupta (2006) observed that the Weibull distributions with equal shape parameters fit to both these data sets.

Data Set 1 (gauge length of 20 mm):

1.312 1.314 1.479 1.552 1.700 1.803 1.861 1.865 1.944 1.958 1.966 1.997 2.006 2.021 2.027 2.055 2.063 2.098 2.140 2.179 2.224 2.240 2.253 2.270 2.272 2.274 2.301 2.301 2.359 2.382 2.382 2.426 2.434 2.435 2.478 2.490 2.511 2.514 2.535 2.554 2.566 2.570 2.586 2.629 2.633 2.642 2.648 2.684 2.697 2.726 2.770 2.773 2.800 2.809 2.818 2.821 2.848 2.880 2.954 3.012 3.067 3.084 3.090 3.096 3.128 3.233 3.433 3.585 3.585

Data Set 2 (gauge length of 10 mm):

1.901 2.132 2.203 2.228 2.257 2.350 2.361 2.396 2.397 2.445 2.454 2.474 2.518 2.522 2.525 2.532 2.575 2.614 2.616 2.618 2.624 2.659 2.675 2.738 2.740 2.856 2.917 2.928 2.937 2.937 2.977 2.996 3.030 3.125 3.139 3.145 3.220 3.223 3.235 3.243 3.264 3.272 3.294 3.332 3.346 3.377 3.408 3.435 3.493 3.501 3.537 3.554 3.562 3.628 3.852 3.871 3.886 3.971 4.024 4.027 4.225 4.395 5.020

Therefore, we observe the following upper record values:

Set of 66 record values from data set 1:

Set of 62 record values from data set 2:

 $\begin{array}{c} 1.9010 \ 2.1320 \ 2.2030 \ 2.2280 \ 2.2570 \ 2.3500 \ 2.3610 \ 2.3960 \ 2.3970 \ 2.4450 \ 2.4540 \ 2.4740 \\ 2.5180 \ 2.5220 \ 2.5250 \ 2.5320 \ 2.5750 \ 2.6140 \ 2.6160 \ 2.6180 \ 2.6240 \ 2.6590 \ 2.6750 \ 2.7380 \\ 2.7400 \ 2.8560 \ 2.9170 \ 2.9280 \ 2.9370 \ 2.9770 \ 2.9960 \ 3.0300 \ 3.1250 \ 3.1390 \ 3.1450 \ 3.2200 \\ 3.2230 \ 3.2350 \ 3.2430 \ 3.2640 \ 3.2720 \ 3.2940 \ 3.3320 \ 3.3460 \ 3.3770 \ 3.4080 \ 3.4350 \ 3.4930 \\ 3.5010 \ 3.5370 \ 3.5540 \ 3.5620 \ 3.6280 \ 3.8520 \ 3.8710 \ 3.8860 \ 3.9710 \ 4.0240 \ 4.0270 \ 4.2250 \\ 4.3950 \ 5.0200 \end{array}$

Using the method of Profile Log-likelihood before applying Newton-Raphson method, the Maximum Likelihood estimates of the parameters of Weibull distribution fitting data set 1 with scale parameter λ_x and shape parameter p_x are $\hat{\lambda}_x = 214.1314$ and $\hat{p}_x = 5.5049$ respectively. Similarly, the Maximum Likelihood estimates of the parameters of Weibull distribution fitting data set 2 with scale parameter λ_y and shape parameter p_y are $\hat{\lambda}_y = 424.5736$ and $\hat{p}_y = 5.0494$ respectively. Based on the upper record values, $R_n = R_{65} = 3.5850$, $G(R_n) = G(R_{65}) = 2.1872e + 03$, $R_m = R_{61} = 5.02$, $G(R_m) = G(R_{61}) = 9.4361e + 03$. The UMVUE of stress-strength reliability, $\tilde{P} = 0.1788$.

5.2 Simulation Studies

In order to obtain estimates under this scheme, we have generated (by inverse cumulative density method) 10, 00,000 samples of size 100 each from the distribution given in (2.1) with $(x; a, \underline{\theta}) = x^p, a = 0, p = 2, \lambda = 5$. Assuming the data represents the life-span of items in hours, for t = 1 and fixing the no. of record values to be 7 (n = 6), the no. of samples obtained are 1,18,282. $G(R_n) = 25.9493$, R(t) = 0.8187, MLE of $\lambda: \hat{\lambda} = 5.1899$, UMVUE of $\lambda: \tilde{\lambda} = 5.1899$, MLE of $R(t): \hat{R}(t) = 0.8545$, UMVUE of $R(t): \tilde{R}(t) = 0.8247$, Variance of UMVUE of $R(t): Var[\tilde{R}(t)] = 0.003508$, MSE of MLE of $R(t): MSE[\hat{R}(t)] = 0.006613$.

In order to obtain the estimate of *P* under this scheme, we have generated 10,000 samples of size 100 each from the distribution of *X* and *Y* when they belong to the same family of distributions. The samples are independently generated from (2.1) with $G(x; a, \underline{\theta}) = x^p$, $a = 0, p = 2, \lambda = 5.5$. Fixing the no. of records from distribution of *X* to be n = 5 and the no. of records from distribution of *Y* to be m = 7. It can be easily shown that $P = P(X > Y) = \frac{1}{2}$. The UMVUE of $P: \tilde{P} = 0.5543$ and MLE of $P: \hat{P} = 0.5447$. Now, when *X* and *Y* belong to different families of distributions, samples are independently generated from (2.1) with $G(x; a_1, \underline{\theta_1}) = x^{p_1}, a_1 = 0, p_1 = 2, \lambda_1 = 5, H(y; a_2, \underline{\theta_2}) = y^{p_2}, a_2 = 0, p_2 = 3, \lambda_2 = 7$. Fixing the no. of records from distribution of *X* to be n = 10 and the no. of records from distribution of *Y* to be m = 12. It can be easily shown that $P = \frac{p_2}{\lambda_2} \int_{y=0}^{\infty} y^{p_2-1} \exp\left(-\frac{y^{p_2}}{\lambda_2} - \frac{y^{p_1}}{\lambda_1}\right) dy = 0.5632$. The UMVUE of $P: \tilde{P} = 0.5301$ and MLE of $P: \hat{P} = 0.5209$.

In order to investigate the performance of the estimators obtained under this scheme, we have evaluated $Var(\tilde{R}(t))$ and $MSE(\hat{R}(t))$ for $G(x; a, \underline{\theta}) = x^p$, a = 0, p = 0.77, $\lambda = 6.88$. Table 1 gives $Var(\tilde{R}(t))$ and $MSE(\hat{R}(t))$ for t = 1(1)30 and n = 8(1)17. Figure 1 compares the variance UMVUE of reliability function with the mean square error of MLE of reliability function calculated in Table 1 as time t increases for n = 17.

In the theory developed in Section 4, for testing the hypothesis $H_0: \lambda = \lambda_0$ against $H_1: \lambda \neq \lambda_0$ under this scheme, we have considered the following sample.

Sample 1:

61.0260 67.1303 70.4844 81.8177 101.8750 105.5080 110.9864 123.1468 164.0256 200.8713 281.5592 295.6992 303.7137 318.1099 368.2300

Now with the help of Chi-Square tables at 5% level of significance, we obtained $k_0 = 57.7602$ and $k_0' = 161.6086$. Hence, in this case we may accept H_0 at 5% level of significance since $G(R_{14}) = 94.6045$.

Again, for testing $H_0: \lambda \le \lambda_0$ against $H_1: \lambda > \lambda_0$. we have considered the above Sample 1. Now at 5% level of significance we obtained $k_0'' = 63.6147$ and hence, in this case we may accept H_0 at 5% level of significance since $G(R_{14}) = 94.6045$. In order to test $H_0: P = P_0$ against $H_1: P \neq P_0$.under this scheme, we have considered the following Sample X and Sample Y.

Sample *X*:

1.3557 2.0975 2.1051 2.1916 2.3850 2.4133 2.4296 2.5964 2.7435 2.8080 2.8404 2.8719 2.9337 3.0365

Sample *Y*:

0.9105 1.4416 1.5719 1.8083 1.8614 1.8779 1.8879 1.8998 1.9696 2.1518 2.2026 2.2114 2.2599 2.2639 2.2695 2.3423 2.3466 2.3479 2.5674 2.5716

For these two samples we obtained $\frac{G(R_n)}{G(R_m^*)} = 0.7559$. Now, with the help of F – tables at 5% level of significance, we obtained $k_2 = 0.2506$ and $k'_2 = 1.0069$. Hence, in this case we may accept H_0 at 5% level of significance.

n	8		9		10		11		12	
t	Var[UMVUE(R(t))]	MSE[MLE(R(t))]								
1	0.00216	0.00642	0.00190	0.00684	0.00170	0.00272	0.00153	0.00336	0.00140	0.00203
2	0.00497	0.01471	0.00439	0.01595	0.00393	0.00606	0.00356	0.00767	0.00325	0.00457
3	0.00758	0.02236	0.00671	0.02460	0.00602	0.00900	0.00546	0.01159	0.00499	0.00681
4	0.00979	0.02891	0.00869	0.03222	0.00781	0.01136	0.00710	0.01488	0.00650	0.00864
5	0.01160	0.03430	0.01032	0.03868	0.00929	0.01319	0.00844	0.01752	0.00774	0.01006
6	0.01302	0.03861	0.01160	0.04403	0.01045	0.01453	0.00951	0.01957	0.00873	0.01112
7	0.01410	0.04197	0.01257	0.04834	0.01134	0.01546	0.01033	0.02109	0.00948	0.01186
8	0.01488	0.04450	0.01328	0.05175	0.01200	0.01606	0.01093	0.02217	0.01004	0.01235
9	0.01541	0.04633	0.01377	0.05436	0.01244	0.01638	0.01135	0.02287	0.01043	0.01262
10	0.01572	0.04755	0.01406	0.05629	0.01271	0.01648	0.01160	0.02325	0.01067	0.01272
11	0.01585	0.04827	0.01419	0.05761	0.01284	0.01641	0.01172	0.02339	0.01079	0.01268
12	0.01584	0.04856	0.01419	0.05844	0.01285	0.01619	0.01174	0.02331	0.01080	0.01253
13	0.01571	0.04851	0.01408	0.05883	0.01275	0.01588	0.01166	0.02306	0.01073	0.01230
14	0.01548	0.04817	0.01388	0.05886	0.01258	0.01548	0.01150	0.02268	0.01059	0.01201
15	0.01518	0.04759	0.01361	0.05858	0.01234	0.01502	0.01129	0.02219	0.01040	0.01166
16	0.01481	0.04683	0.01329	0.05805	0.01205	0.01452	0.01103	0.02162	0.01016	0.01128
17	0.01440	0.04591	0.01293	0.05731	0.01173	0.01399	0.01073	0.02099	0.00989	0.01088
18	0.01395	0.04487	0.01253	0.05640	0.01137	0.01344	0.01040	0.02032	0.00959	0.01046
19	0.01348	0.04374	0.01211	0.05534	0.01099	0.01288	0.01006	0.01961	0.00928	0.01003
20	0.01300	0.04254	0.01167	0.05417	0.01060	0.01232	0.00970	0.01889	0.00895	0.00960
21	0.01250	0.04128	0.01123	0.05291	0.01020	0.01176	0.00934	0.01815	0.00861	0.00917
22	0.01200	0.04000	0.01078	0.05159	0.00979	0.01121	0.00897	0.01742	0.00827	0.00875
23	0.01150	0.03869	0.01033	0.05021	0.00938	0.01068	0.00859	0.01668	0.00793	0.00833
24	0.01100	0.03737	0.00989	0.04880	0.00898	0.01015	0.00823	0.01596	0.00759	0.00793
25	0.01052	0.03606	0.00945	0.04737	0.00858	0.00965	0.00786	0.01525	0.00725	0.00754
26	0.01004	0.03475	0.00902	0.04592	0.00819	0.00916	0.00750	0.01455	0.00692	0.00716
27	0.00957	0.03346	0.00860	0.04447	0.00781	0.00869	0.00716	0.01387	0.00660	0.00679
28	0.00912	0.03219	0.00820	0.04302	0.00744	0.00824	0.00682	0.01322	0.00629	0.00644
29	0.00868	0.03094	0.00780	0.04159	0.00708	0.00781	0.00649	0.01258	0.00598	0.00611
30	0.00825	0.02972	0.00742	0.04017	0.00674	0.00739	0.00617	0.01197	0.00569	0.00579

Table 1: Mean Square Error of MLE and UMVUE of Reliability function

n	13		14		15		16		17	
t	Var[UMVUE(R(t))]	MSE[MLE(R(t))]								
1	0.00128	0.00146	0.00119	0.00143	0.00110	0.00129	0.00103	0.00130	0.00097	0.00214
2	0.00299	0.00328	0.00277	0.00327	0.00258	0.00297	0.00242	0.00300	0.00227	0.00496
3	0.00460	0.00490	0.00427	0.00497	0.00398	0.00451	0.00372	0.00458	0.00350	0.00758
4	0.00599	0.00623	0.00556	0.00640	0.00518	0.00582	0.00486	0.00593	0.00457	0.00981
5	0.00714	0.00727	0.00663	0.00757	0.00619	0.00689	0.00580	0.00704	0.00546	0.01163
6	0.00806	0.00805	0.00749	0.00849	0.00699	0.00772	0.00656	0.00792	0.00617	0.01306
7	0.00877	0.00861	0.00815	0.00919	0.00761	0.00836	0.00714	0.00859	0.00672	0.01414
8	0.00929	0.00899	0.00864	0.00969	0.00807	0.00883	0.00758	0.00908	0.00714	0.01491
9	0.00965	0.00922	0.00898	0.01004	0.00839	0.00914	0.00788	0.00943	0.00743	0.01542
10	0.00988	0.00933	0.00919	0.01025	0.00860	0.00934	0.00807	0.00964	0.00761	0.01572
11	0.00999	0.00934	0.00930	0.01035	0.00870	0.00943	0.00817	0.00975	0.00770	0.01583
12	0.01000	0.00926	0.00932	0.01035	0.00872	0.00943	0.00819	0.00976	0.00772	0.01580
13	0.00994	0.00913	0.00926	0.01028	0.00867	0.00937	0.00815	0.00971	0.00768	0.01564
14	0.00982	0.00895	0.00915	0.01015	0.00856	0.00925	0.00805	0.00959	0.00759	0.01539
15	0.00964	0.00873	0.00898	0.00997	0.00841	0.00909	0.00791	0.00943	0.00746	0.01506
16	0.00942	0.00848	0.00878	0.00976	0.00822	0.00889	0.00773	0.00923	0.00730	0.01467
17	0.00917	0.00821	0.00855	0.00951	0.00801	0.00866	0.00753	0.00900	0.00711	0.01423
18	0.00890	0.00793	0.00830	0.00924	0.00777	0.00842	0.00731	0.00874	0.00690	0.01377
19	0.00861	0.00765	0.00802	0.00895	0.00752	0.00815	0.00707	0.00847	0.00667	0.01327
20	0.00830	0.00735	0.00774	0.00865	0.00725	0.00788	0.00682	0.00819	0.00644	0.01277
21	0.00799	0.00706	0.00745	0.00834	0.00698	0.00760	0.00657	0.00790	0.00620	0.01225
22	0.00767	0.00677	0.00716	0.00804	0.00671	0.00732	0.00631	0.00761	0.00596	0.01174
23	0.00736	0.00648	0.00686	0.00773	0.00643	0.00704	0.00605	0.00731	0.00571	0.01122
24	0.00704	0.00620	0.00657	0.00742	0.00616	0.00676	0.00579	0.00702	0.00547	0.01071
25	0.00673	0.00592	0.00628	0.00711	0.00589	0.00648	0.00554	0.00673	0.00523	0.01022
26	0.00643	0.00565	0.00599	0.00681	0.00562	0.00621	0.00529	0.00644	0.00499	0.00973
27	0.00613	0.00539	0.00572	0.00652	0.00536	0.00594	0.00504	0.00616	0.00476	0.00926
28	0.00584	0.00514	0.00544	0.00623	0.00510	0.00568	0.00480	0.00589	0.00453	0.00880
29	0.00555	0.00490	0.00518	0.00595	0.00486	0.00542	0.00457	0.00562	0.00431	0.00835
30	0.00528	0.00466	0.00493	0.00568	0.00462	0.00518	0.00434	0.00536	0.00410	0.00793



Figure 1: Mean Square Error of MLE and UMVUE of Reliability function for sample size n = 17.

Discussion

A lot of work has been done in the literature to estimate and test the hypotheses for the reliability functions. In the present paper, we have proposed a family of lifetime distributions which covers as many as fourteen distributions as specific cases, which are useful in reliability theory. Based on record values, estimation and testing procedures are developed for this family of lifetime distributions. Thus, a unified theory is developed.

From Table 1, it is clear that at any given time t and for any sample size n, the variance UMVUE of reliability function is always less than the mean square error of MLE of reliability function.

Conclusion

In Table 1, a comparative study of efficiencies of UMVUE and MLE of reliability function based on record values has been performed. It is clear from simulation results that UMVUES of the reliability function are more efficient than MLE of reliability function. Thus, a comparison between efficiencies of UMVUES and MLES has been discussed by estimating the sampled pdf to obtain the variance and mean square error of estimators and an interrelationship between efficiencies of the two estimators has been established by performing simulation studies.

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References

- 1. Ahsanullah, M. (1980): Linear prediction of record values for the two parameter exponential distribution. *Ann. Inst. Statist. Math.*, **32**, Part A, 363-368.
- 2. Arnold, B. C., Balakrishan, N., Nagaraja, H. N. (1992): A First Course in Order Statistics. John Wiley & Sons, New York.
- 3. Arashi, M., Emadi, M. (2008): Evidential inference based on record data and inter-record times. *Stat.Papers*, **13(8)**, 380–210.
- 4. Asgharzadeh, A., Valiollahi, R., Raqab. M. Z. (2011): Stress-strength reliability of Weibull distribution based on progressively censored samples. *SORT*, **35**, 103-124.
- 5. Awad, A. M., Gharraf, M. K. (1986): Estimation of P(Y<X) in the Burr case: A Comparative Study. *Commun. Statist. Simul.*, **15(2)**, 389-403.
- 6. Badar, M. G., Priest, A. M. (1982): Statistical aspects of fiber and bundle strength in hybrid composites. In: Hayashi, T., Kawata, K., Umekawa, S. (Eds.). *Progress in Science and Engineering Composites, ICCM-IV, Tokyo*, 1129-1136.
- 7. Balakrishan, N., Ahsanullah, M., Chan, P.S. (1995): On the logistic record values and associated inference. *Journal of Applied Statistical Science*, **2**, 233-248.
- 8. Bartholomew, D. J. (1957): A problem in life testing. Jour. Amer. Statist. Assoc., 52, 350-355.
- 9. Bartholomew, D. J. (1963): The sampling distribution of an estimate arising in life testing. *Technometrics*, **5**, 361-374.
- 10. Basu, A. P. (1964): Estimates of reliability for some distributions useful in life testing. *Technometrics*, **6**, 215-219.
- Belaghi, R. A., Arashi, M., Tabatabaey, S. M. M. (2015): On the Construction of Preliminary Test Estimator Based on Record Values for the Burr XII Model. *Communications in Statistics* - *Theory and Methods*, 44(1), 1-23, DOI:10.1080/03610926.2012.733473
- 12. Burr, I. W (1942): Cumulative Frequency Functions, *The Annals of Mathematical Statistics* **13 (2)**, 215-232
- 13. Burr, I.W., Cislak, P.J. (1968): On a general system of distributions: I. Its curve-shaped characteristics; II. The sample median, *Journal of the American Statistical Association*, **63**, 627-635.
- 14. Chandler, K. N. (1952): The distribution and frequency of record values. *Journal of the Royal Statistical Society, Series B*, **14**, 220-228.
- 15. Chao, A. (1982): On comparing estimators of Pr{X>Y} in the exponential case. *IEEE Trans. Reliability*, **R-26**, 389-392.
- 16. Chaturvedi,A and Kumari,T (2015): Estimation and testing procedures for the reliability functions of a family of lifetime distributions. *interstat*.statjournals.net/ YEAR/ 2015/ abstracts/1306001.php
- 17. Chaturvedi, A. and Pathak, A. (2012): Estimation of the reliability functions for exponentiated Weibull distribution. J. Stat. & Appl, 7, 1-8.
- 18. Chaturvedi, A. and Pathak, A. (2013): Bayesian estimation procedures for three parameter exponentiated Weibull distribution under entropy loss function and type II censoring.*interstat*.statjournals.net/YEAR/2013/abstracts/1306001.php

- 19. Chaturvedi, A. and Pathak, A. (2014): Estimation of the Reliability Function for four-Parameter Exponentiated Generalized Lomax Distribution. *IJSER*, **5(1)**, 1171-1180.
- 20. Chaturvedi, A. and Rani, U. (1997): Estimation procedures for a family of density functions representing various life-testing models. *Metrika*, **46**, 213-219.
- 21. Chaturvedi, A. and Rani, U. (1998): Classical and Bayesian reliability estimation of the generalized Maxwell failure distribution. *Jour. Statist. Res.*, **32**, 113-120.
- 22. Chaturvedi, A. and Singh, K. G. (2006): Bayesian estimation procedures for a family of lifetime distributions under squared-error and entropy losses. *Metron*, **64(2)**, 179-198.
- 23. Chaturvedi, A. and Singh, K. G. (2008): A family of lifetime distributions and related estimation and testing procedures for the reliability function. *Jour. Appl. Statist. Sci.*, **16(2)**, 35-50.
- 24. Chaturvedi, A. and Surinder, K. (1999): Further remarks on estimating the reliability function of exponential distribution under type I and type II censorings. *Brazilian Jour. Prob. Statist.*, **13**, 29-39.
- 25. Chaturvedi., A. and Tomer, S. K. (2002): Classical and Bayesian reliability estimation of the negative binomial distribution. *Jour. Applied Statist Sci.*, **11**, 33-43.
- 26. Chaturvedi, A. and Tomer, S. K. (2003): UMVU estimation of the reliability function of the generalized life distributions. *Statist. Papers*, **44(3)**, 301-313.
- 27. Chen, Z. (2000): A new two- parameter lifetime distribution with bathtub shape or increasing failure rate function. *Statistics & Probability Letters*, **49**, 155-161.
- 28. Constantine, K., Karson, M. and Tse, S. K. (1986): Estimation of P(Y<X) in the gamma case. *Commun. Statist. Simul.*, **15(2)**, 365-388.
- 29. Glick, N. (1978): Breaking records and breaking boards. *American Mathematical Monthly*, **85**, 543-551.
- 30. Habibi Rad, A., Arghami, N. R., Ahmadi, J. (2006): Statistical evidence in experiments and in record values. *Commun. Stat. Theo. Meth.* **35(11)**, 1971–1983.
- 31. Johnson, N. L. (1975): Letter to the editor. *Technometrics*, 17, 393.
- 32. Johnson, N.L and Kotz, S. (1970): Distributions in Statistics-Continuous Univariate Distributons, Vol. 1, *New York: John Wiley & Sons, Vol.* 1-2.
- Khan,R.U., Zia, B. (2009): Recurrence Relations for single and Product moments of record values from Gompertz distribution and a characterization. *World Applied Sciences Journal*, 7(10), 1331-1334.
- 34. Kelly, G. D., Kelly, J.A. Schucany, W. R. (1976): Efficient estimation of P(Y<X) in the exponential case. *Technometrics*, **18**, 359-360.
- 35. Kundu, D., Gupta, R. D. (2006): Estimation of P(Y < X) for Weibull distributions. *IEEE Transcations on Reliability*, **55(2)**, 270-280.
- 36. Kundu, D., Raqab, M. Z. (2009): Estimation of R = P(Y < X) for three parameter Weibull distribution. *Statistics and Probability Letters*, **79**, 1839-1846.
- 37. Lai, C. D., Xie, M., Murthy, D. N. P. (2003): Modified Weibull model. *IEEE Trans. Reliability*, **52**, 33-37.
- 38. Lawless, J. F. (1982): Statistical models and methods for lifetime data, *John Wiley & Sons*, *New York*, **10(4)**, 316-317
- 39. Lehmann, E. L. (1959): Testing Statistical Hypotheses. John Wiley and Sons, New York.
- 40. Ljubo, M. (1965): Curves and concentration indices for certain generalized Pareto distributions. *Statist. Rev.*, **15**, 257-260.
- 41. Lomax, K. S. (1954): Business failures. Another example of the analysis of failure data. *Jour. Amer. Statist. Assoc.*, **49**, 847-852.
- 42. Mahmoud, M. A. W., Al-Nagar, H. SH. (2009): On generalized order statistics from linear exponential distribution and its characterization. *Stat Papers*, **50**, 407-418.

- 43. Nagaraja, H. N. (1988a): Record values and related statistics A review. *Communictions in Statistics Theory and Methods*, **17**, 2223-2238.
- 44. Nagaraja, H. N. (1988b): Some characterizations of continuous distributions based on regressions of adjacent order statistics and record values. *Sankhya, Series A*, **50**, 70-73.
- 45. Nelson, R. R. and Sidney, G. W (1982): An Evolutionary Theory of Economic Change, Belknap Press/Harvard University Press: Cambridge.
- 46. Nikulin, M., Haghighi, F. (2006): A chi-squared test for the generalized power weibull family for thehead-and-neck cancer censored data. *Journal of Mathematical sciences*, **133(3)**, 1333-1341.
- 47. Pugh, E.L. (1963): The best estimate of reliability in the exponential case. *Operations Research*, **11**, 57-61.
- 48. Raqab, M. Z., Kundu, D. (2005): Comparison of different estimators of P(Y < X) for a scaled Burr type X distribution. *Communications in Statistics-Simulation and Computation*, **34(2)**, 465-483.
- 49. Razmkhah, M., Ahmadi, J. (2011): Comparing two sampling schemes based on entropy of record statistics. *Stat. Papers*, **53**, 95–106
- 50. Rohtagi, V. K., Saleh, A. K. Md. Ehsanes (2012): An Introduction to Probability and Statistics, Second Edition. *John Wiley & Sons, U.K.*
- 51. Sathe, Y. S., Shah, S. P. (1981): On estimating P(X<Y) for the exponential distribution. *Commun. Statist. Theor. Meth.*, A10, 39-47.
- 52. Sinha, S. K. (1986): Reliability and Life Testing. Wiley Eastern Limited, New Delhi.
- 53. Tadikamalla, P. R. (1980): A look at the Burr and related distributions. *Inter. Statist. Rev.*, **48**, 337-344.
- 54. Tong, H. (1974): A note on the estimation of $P(Y \le X)$ in the exponential case. *Technometrics*, 16, 625.
- 55. Tong, H. (1975): Letter to the editor. *Technometrics*, 17, 393.
- 56. Tyagi, R. K., Bhattacharya, S. K.(1989): A note on the MVU estimation of reliability for the Maxwell failure distribution. *Estadistica*, **41**, 73-79.
- 57. Watson, R. I. (1952): Research design and methodology in evaluating the results of psychotherapy, *J. Clin. Psychol.*, **8**, 29–33. DOI:10.1002/1097-4679(195201)8:1<29::AID-JCLP2270080107>3.0.CO;2-O